

Dielectric characterization of hydrothermally PREPARED (Cu,Sb)-doped $\text{BaTi}_{1-x}\text{Zr}_x\text{O}_3$

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Powders of copper-doped $\text{BaTi}_{1-x}\text{Zr}_x\text{O}_3$ have been synthesized using the hydrothermal process. The starting materials were powders of BaO and TiO_2 , $\text{ZrO}_2 \cdot x\text{H}_2\text{O}$ gel, and an aqueous solution of Cu^{2+} / Sb^{5+} . The obtained powders were cold compacted and sintered at 1280°C . Impedance spectroscopy measurements have been performed on these ceramics and the results were analyzed using the empiric Cole-Cole model. A procedure to evaluate the electric properties of the grain boundary and bulk grain has been developed based on electric polarization model of double layered dielectrics.

I. Introduction:

Recently, there has been an increased interest in ferroelectric materials because of their growing use in electronic, electrooptic, optical and microwave devices[1,2]. The study of pure and doped perovskite-type $\text{BaTi}_{1-x}\text{Zr}_x\text{O}_3$ is of great interest, since this material possesses interesting properties which makes it potentially useful for these applications. It is known that the curie point of $\text{BaTi}_{1-x}\text{Zr}_x\text{O}_3$ can be adjusted by varying the Ti:Zr ratio[3,4]. As a result, various properties of this material can be tailored for specific applications and operating temperatures.

In this paper, we present structural and dielectric characterization of hydrothermally prepared Cu and Sb-doped $\text{BaTi}_{1-x}\text{Zr}_x\text{O}_3$ ($x=0$ (BTO) and $x=0.2$ (BZT)). We also present an attempt of evaluation of the individual electrical properties of bulk grains and grain boundaries using the frequency dependence of the dielectric permittivity.

II. Experimental procedure:

A solution of Ba(OH)_2 is prepared by dissolving barium oxide (BaO , 99.9 %) in distilled water. On the other hand, Zirconium nitrate $\text{Zr(NO}_3)_2 \cdot 7\text{H}_2\text{O}$ was dissolved in water and ammonium hydroxide (NH_4OH) was subsequently added to form a $\text{ZrO}_2 \cdot y\text{H}_2\text{O}$ precipitate. Finally, a mixture (Ba(OH)_2 , TiO_2 , $\text{ZrO}_2 \cdot y\text{H}_2\text{O}$, Cu^{2+} or Sb^{5+} aqueous solution) was introduced in an autoclave in the presence of sodium hydroxide (NaOH) and heated to 140°C and maintained at this temperature for 14 hours. The obtained product is filtered, washed to eliminate Na^+ ions and dried at 100°C .

The dried powders were cold-pressed (0.6 Tons/cm^2) into pellets of diameter 13 mm and thickness 0.5 mm, they were subsequently calcined at 1280°C for 3 hours. The X-ray diffraction (XRD) studies were

performed in a station equipped with a Siemens M386-X-A3 goniometer using the $\text{CuK}\alpha$ radiation. The dielectric permittivity was measured as a function of temperature at 1kHz, and as a function of frequency for various temperatures above the Curie point, for frequencies ranging from 40 to 100Hz, using a Keithley 33230 LCZ meter controlled by a computer. The pellets used for this purpose were coated by silver paint which is subsequently dried in air. All the measurements were performed in a vacuum chamber evacuated with a mechanical pump down to a pressure of 10 Pa.

III. Results and discussion:

Figure 1 present typical XRD diagrams of calcined 1% Cu/Sb-doped BTO and BZT powders. These spectra showed room-temperature stabilization of the cubic phase (also named pseudo-cubic phase). This stabilization is associated to small grain size of the powders obtained using this method ($0.2\mu\text{m}$ for BTO [5]).

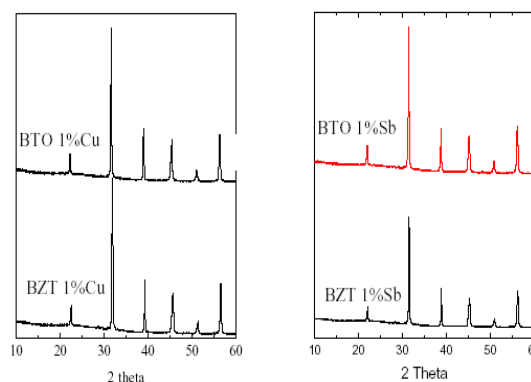


Figure 1: XRD patterns of 1280°C treated 1% Cu and Sb-doped BTO and BZT

The temperature dependence of the dielectric constant of 1% Cu and Sb-doped BTO and BZT is presented in figure 2. In both cases, the effective dielectric constants are small compared with those of solid state reaction prepared BTO ceramics.

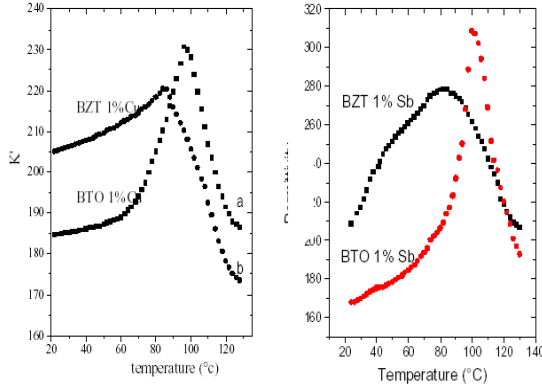


Figure 2: Temperature dependence of permittivity of Cu and Sb-doped BTO and BZT.

On the other hand, these curves denotes a ferroelectric behavior, namely, the ferroelectric to paraelectric (tetragonal to cubic) which occurs around 94°C for Cu and Sb-doped BTO and around 84°C for Cu and Sb-doped BZT.

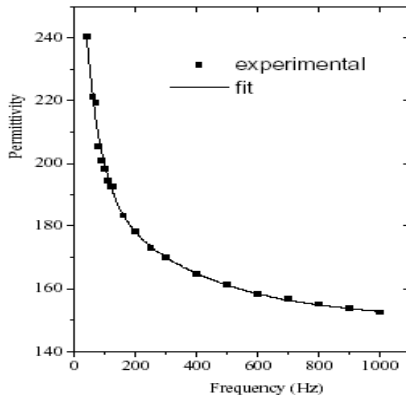


Figure 3: Typical curve of frequency dependence of permittivity

The presence of the tetragonal phase can be explained by the presence of an eventual quadraticity gradient in the grains[9].

The measurements of frequency dependence of the dielectric constant have been performed in the samples for temperatures higher than the transition temperature. Figure 3 shows a typical frequency dependence of the dielectric constant of 1%Cu-doped BTO at 140°C. In this Figure, the dots stand for

measured data. It was not possible to fit the data with the monodispersive Debye formula:

$$K = K_{\infty} + \frac{K_s - K_{\infty}}{1 + j\omega\tau}$$

where K_{∞} and K_s , are high and low frequency permittivities, τ is the relaxation time. This is expected since The Debye's idealized treatment applies only to certain dilute solutions of large molecules in non-polar solvents. In the following we will discuss the fits using the polydispersive cole-cole formula:

$$K = K_{\infty} + \frac{K_s - K_{\infty}}{1 + (j\omega\tau)^a}$$

(line curve in the figure 3) where a is the Cole-Cole parameter. The fitting computations were undertaken on the measured complex impedance data to obtain individual values of K_{∞} , K_s , τ and a .

It is assumed that the sample can be ideally represented by a double layer dielectric, representing bulk grain and grain boundaries. Based on this model, K_{∞} , K_s , and τ can be expressed as[10]:

$$K_s = \frac{(d_1 K_1 \frac{2}{2} + d_2 K_2 \frac{2}{1})(d_1 + d_2)}{(d_1 \frac{2}{2} + d_2 \frac{1}{1})^2}$$

$$K_{\infty} = \frac{K_2 K_1 (d_1 + d_2)}{d_1 K_2 + d_2 K_1} = \frac{d_1 K_2 + d_2 K_1}{d_1 \frac{2}{2} + d_2 \frac{1}{1}} K_0$$

Where d_i , s_i and K_i ($i=1,2$) are thickness, dc conductivity and permittivity respectively of each layer. Subscripts 1 and 2 represent bulk grain and grain boundary, respectively. The mean grain size d_1 is much larger than the thickness d_2 of the highly resistive grain boundary layer: $d_1 \gg d_2$. The relation $d_1 s_2 \gg d_2 s_1$ holds also due to the highly resistive character of the grain boundary layers. In these conditions, equations 1, 2 and 3 can be reduced to :

$$1 = \left(\frac{K_0}{K_s - K_{\infty}} \right)^2 \quad K_2 = \frac{d_2}{d_1} K_s$$

$$K_1 = \frac{K_s K_{\infty}}{K_s - K_{\infty}}$$

and

Values of s_1 , K_1 and $(d_2/d_1) \cdot K_2$ can then be deduced from those of K_{∞} , K_s , and τ .

The variation of the bulk grain dc-conductivity with temperature (Figure 4) is found to fit an arrhenius law $s_1 = s_0 \cdot \exp(-E/kT)$, where s_0 is the high temperature conductivity and E is the activation energy.

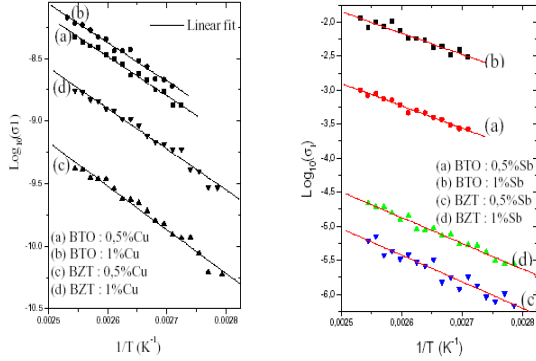


Figure 4: Temperature dependence of the calculated dc conductivity of the bulk grain of Cu and Sb-doped BTO and BZT.

The obtained activation energies are shown in table 1. A slight variation of the activation energy with Cu doping is observed in the case of BTO, while, in the case of BZT, this variation is very pronounced.

Samples		E (eV)
TO	1%Cu	0.55
	0.5%Cu	0.53
ZT	1%Cu	0.57
	0.5%Cu	0.62
TO	1%Sb	0.62
	0.5%Sb	0.65
ZT	1% Sb	0.75
	0.5% Sb	0.77

Table 1: Activation energies of the calculated dc conductivities of the bulk grain.

Figure 5 show the temperature dependence of $(d_2/d_1) \cdot K_2$. Only a slight variation of this argument., with an average value of 246 for Cu-doped BTO and 238 for doped BZT. The corresponding values K_2 are rather weak since the factor (d_2/d_1) is very small ($d_2/d_1 \ll 1$). The low value of K_2 can explain the low values of the effective dielectric constant of the samples.

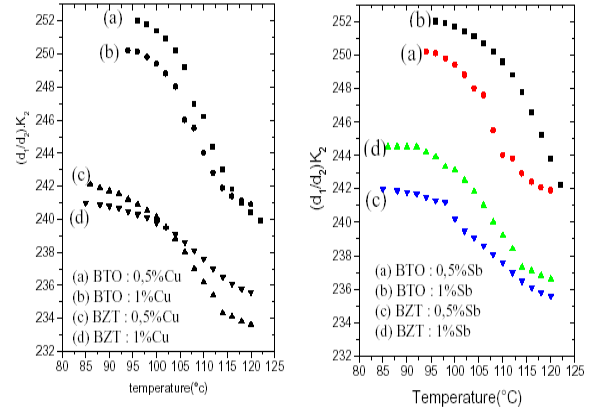


Figure 5: Temperature dependence of the calculated $(d_1/d_2) \cdot K_2$ of Cu and Sb-doped BTO and BZT.

Figures 6 represent the calculated dielectric constant of the bulk grain. The curves show a diffuse character of the transition. This is more pronounced in BZT than in BTO and is well marked for 1% doped than for 0,5% doped samples.

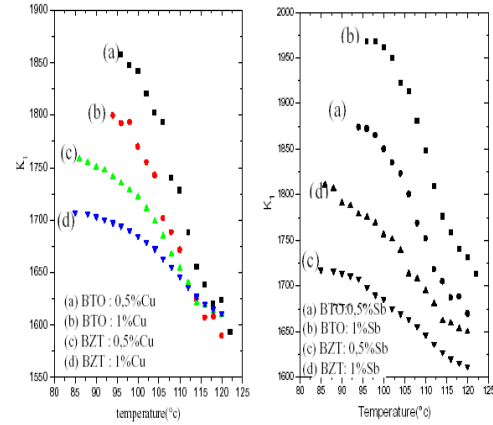


Figure 6: Temperature dependence of the calculated dielectric constant of the bulk grain of Cu and Sb-doped BTO and BZT.

This result can be attributed to spatial fluctuations in the concentrations of the substituted ions leading to the coexistence of regions of different curie temperature [11]. The diffuse nature of the transition may also be attributed to the quadraticity gradient which leads to a distribution of transition temperatures.

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